



# 深圳康比电子有限公司

**KANGBI TECHNOLOGY INDUSTRY CO.,LTD.**

## 产品规格书

### SAMPLE APPROVAL SHEET

CUSTOMER客户:

\_\_\_\_\_

SIZE UP规格:

**TO-39 -DIP**

MODEL型号:

**R433.92M**

NUMBER数量:

\_\_\_\_\_

DATE日期:

\_\_\_\_\_

### Customer's Approval Certificate

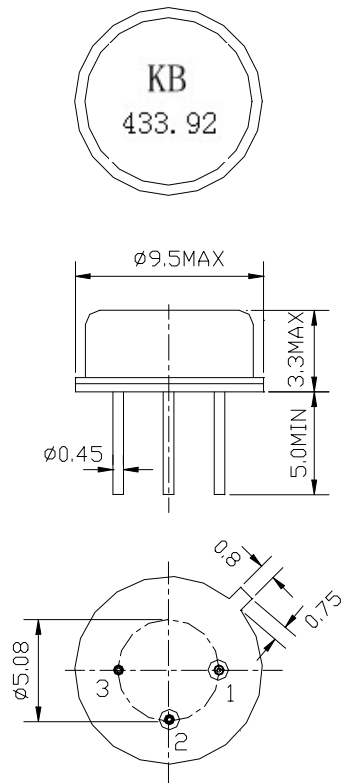
Please return this copy as a certification of  
Your approval

Checked & Approval by:

Date:

### 1. Package Dimension ( TO-39/3A )

Unit: mm



Pin No. Function

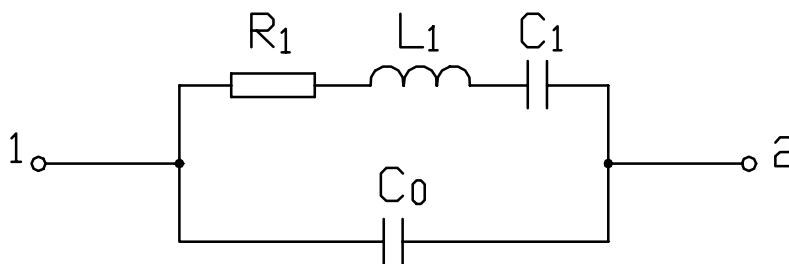
- 1. Input
- 2. Output
- 3. Ground

### 2. Marking

KB  
R433.92

- 1. Color: Black or Blue
- 2. D: Manufacture's logo
- 3. R1: One-port SAW Resonator
- 4. 433.92: Center Frequency ( MHz)

### 3. Equivalent LC Model



## 4. Performance

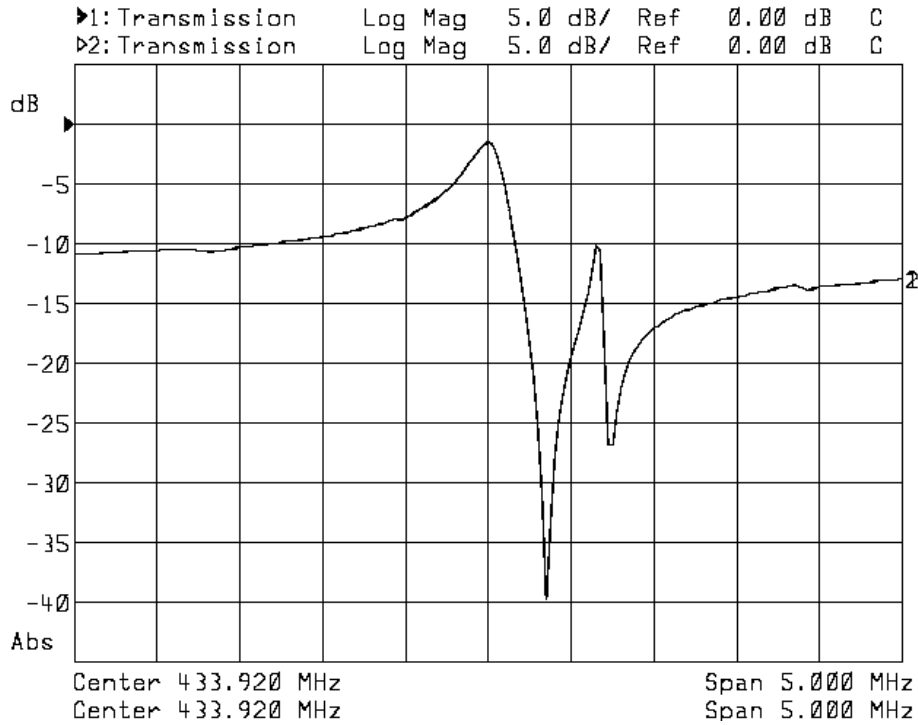
### 4.1 Maximum Rating

|                       |                 |
|-----------------------|-----------------|
| DC Voltage $V_{DC}$   | 10V             |
| AC Voltage $V_{PP}$   | 10V (50Hz/60Hz) |
| Operation Temperature | -40 °C to +85°C |
| Storage Temperature   | -45 °C to +85°C |
| RF Power Dissipation  | 0dBm            |

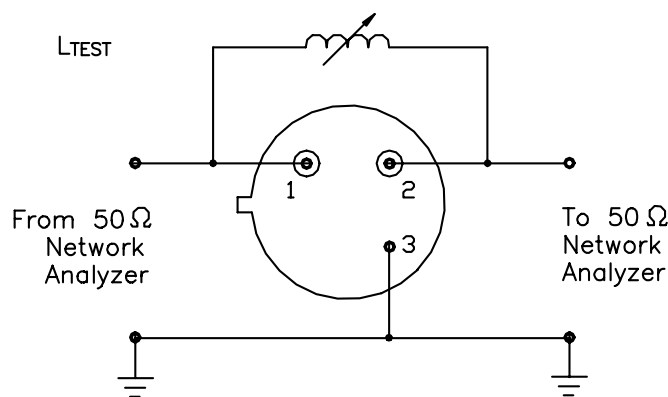
### 4.2 Electronic Characteristics

| Item                       | Units                          | Minimum             | Typical        | Maximum |
|----------------------------|--------------------------------|---------------------|----------------|---------|
| Center Frequency           | MHz                            | 433.845             | 433.920        | 433.995 |
| Insertion Loss             | dB                             | —                   | 1.2            | 2.5     |
| Quality Factor             | Unloaded Q                     | —                   | 11,000         | —       |
|                            | 50 $\Omega$ Loaded Q           | —                   | 2,000          | —       |
| Temperature                | Turnover Temperature           | °C                  | 25             | —       |
| Stability                  | Turnover Frequency             | KHz                 | f <sub>o</sub> | —       |
|                            | Freq. Temp. Coefficient        | ppm/°C <sup>2</sup> | 0.032          | —       |
| Frequency Aging            | ppm/yr                         | —                   | <±10           | —       |
| DC Insulation Resistance   | M $\Omega$                     | 1.0                 | —              | —       |
| RF Equivalent<br>RLC Model | Motional Resistance $R_1$      | $\Omega$            | 18             | 26      |
|                            | Motional Inductance $L_1$      | $\mu$ H             | 86             | —       |
|                            | Motional Capacitance $C_1$     | fF                  | 1.56           | —       |
|                            | Shunt Static Capacitance $C_0$ | pF                  | 1.7            | 2.0     |

### 4.3 Frequency Characteristics



### 4.4 Test Circuit



Note: Reference temperature shall be  $25 \pm 2^\circ\text{C}$ . However, the measurement may be carried out at  $5^\circ\text{C}$  to  $35^\circ\text{C}$  unless there is a dispute.

## 5. Reliability

5.1 Mechanical Shock: The components shall remain within the electrical specifications after 1000 shocks, acceleration  $392 \text{ m/s}^2$ , duration 6 milliseconds.

5.2 Vibration Fatigue: The components shall remain within the electrical specifications after loaded vibration at 20 Hz, amplitude 1.5 mm, for 2 hours.

5.3 Terminal Strength: The components shall remain within the electrical specifications after pulled 2 kgs weight for 10 seconds towards an axis of each terminal.

5.4 High Temperature Storage: The components shall remain within the electrical specifications after being kept at the  $85^\circ\text{C} \pm 2^\circ\text{C}$  for 48 hours, then kept at room temperature for 2 hours.

5.5 Low Temperature Storage: The components shall remain within the electrical specifications after being kept at the  $-25^\circ\text{C} \pm 2^\circ\text{C}$  for 48 hours, then kept at room temperature for 2 hours.

5.6 Temperature Cycle: The components shall remain within the electrical specifications after 5 cycles of high and low temperature testing ( one cycle:  $80^\circ\text{C}$  for 30 minutes  $\rightarrow$   $25^\circ\text{C}$  for 5 minutes  $\rightarrow$   $-25^\circ\text{C}$  for 30 minutes ) then kept at room temperature for 2 hours.

5.7 Humidity Test: The components shall remain within the electrical specifications after being kept at the condition of ambient temperature  $40 \pm 2^\circ\text{C}$ , and 90~95% RH for 48 hours, then kept at room temperature and normal humidity for 2 hours.

5.8 Solder-heat Resistance: The components shall remain within the electrical specifications after dipped in the solder at  $260^\circ\text{C}$  for  $10 \pm 1$  seconds, then kept at room temperature for 2 hours. (Terminal must be dipped leaving 1.5 mm from the case).

5.9 Solderability: Solderability of terminal shall be kept at more than 80% after dipped in the solder flux at  $230^\circ\text{C} \pm 5^\circ\text{C}$  for  $5 \pm 1$  seconds.

## 6. Remarks

### 6.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

### 6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning.

### 6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.